

RZ/G2L Thermal Management Guideline

# Application Note

R01AN6107EJ0100 Rev.1.00 Oct 07, 2021

## Information

The calculation results of power consumption, Limit Ta and Oja are shown after the next page as reference.

Please choose the use case which is similar to your application, and refer to these results as reference.

## **Target Device**

RZ/G2L



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# **1.** Specification of Junction Temperature

Specification of Tj (junction temperature) is defined as follows. Users have to use this device without violating the following specification.

- Operating temperature
  - -40°C  $\leq$  Tjmax(Max temperature of junction side)  $\leq$  125°C

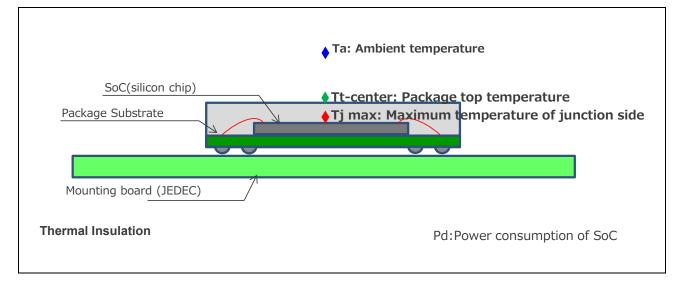
The calculation method of Tjmax is shown on Section 3, Calculation method of Tjmax.

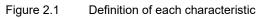
Please confirm Tjmax according to this calculation method.



# 2. Definition of each characteristic

• The temperature at the center of the package surface is defined as Tt-center.





 $\theta$ ja(Thermal resistance between Tj and Ta) =  $\frac{Tjmax - Ta}{Pd}$ 

 $\Psi jt(at Package center) = \frac{Tjmax - T_{t-center}}{Pd}$ 



## 3. Calculation method of Tjmax

- After measuring Pd (Power consumption of Soc) and Tt-center in your environment, please calculate Tjmax using the next formula.
- Please confirm that "Tjmax" which you calculated is within the specification.

 $Tjmax(^{\circ}C) = Tt-center(^{\circ}C) + \Psi jt(at Package center)(^{\circ}C/W) (^{*1}) \times Pd(W)$ 

 Note 1.
 Refer to the table below for Ψjt(at Chip center).

 Ψjt(at Chip center) is calculated value by thermal simulations.

 Refer to Section 5, Thermal simulation model about the thermal simulation model.

 Please remind that Ψjt is limited to the opentop case.

Package Outline	Heat Sink	Ψjt(at Package center) (°C/W)
15mm sq	No	0.78
21mm sq	No	0.75



## 4. Reference Information

#### 4.1 Reference Information

- The calculation results of power consumption are shown after the next page as reference.
- Please choose the use case which is similar to your application, and refer to the power consumption as reference.
- Please confirm the limit Ta of your use case. The limit Ta was calculated from thermal simulation results.

## 4.2 Operation summary in each use case

The power consumptions in 4 use cases were calculated. You choose the use case which is similar to your application, and refer to the power consumption as reference.

• Estimation conditions of power consumption

 $Tj = 125^{\circ}C$ , Power supply (1.1V) = 1.1V, Power Supply (DDR4) = 1.2V, Power Supply (1.8V) = 1.8V, Power Supply (3.3V) = 3.3V, Process = FF process silicon, CPU: Cortex-A55@1.2GHz, DDR4-1600 16bit × 1ch

Table 4.1Operation summary of each use case (1/2)

Use Case	Operation summary	Power consumption (w)
UseCase1	Use case assuming 1 screen display (2D graphics × 1)	2.62
	<ul> <li>CortexA55 (2Core/CPU0: use rate 62%, CPU1: use rate 62%)</li> </ul>	
	• GPU: use rate 65%	
	<ul> <li>System/Bus/Clock: use rate 50%</li> </ul>	
	• VCP: use rate 0%	
	MIPI-DSI: use rate 90%	
	MIPI-CSI: use rate 25%	
	• USB2.0: use rate 0%	
	• Gbit-Ether: use rate 30%	
	• DRAM use rate 28%	
UseCase2	Use case assuming 1 screen display (2D graphics × 1& HD video playback × 1)	2.84
	<ul> <li>CortexA55 (2Core/CPU0: use rate 62%, CPU1: use rate 62%)</li> </ul>	
	• GPU: use rate 65%	
	<ul> <li>System/Bus/Clock: use rate 50%</li> </ul>	
	• VCP: use rate 50%	
	• MIPI-DSI: use rate 90%	
	MIPI-CSI: use rate 25%	
	• USB2.0: use rate 0%	
	• Gbit-Ether: use rate 30%	
	• DRAM use rate 43%	
UseCase3	Use case assuming 1 screen display (3D graphics × 1)	2.68
	<ul> <li>CortexA55 (2Core/CPU0: use rate 62%, CPU1: use rate 62%)</li> </ul>	
	• GPU: use rate 70%	
	<ul> <li>System/Bus/Clock: use rate 55%</li> </ul>	
	• VCP: use rate 0%	
	MIPI-DSI: use rate 90%	
	MIPI-CSI: use rate 25%	
	• USB2.0: use rate 0%	
	• Gbit-Ether: use rate 30%	
	• DRAM use rate 31%	

DRAM use rate 31%



Use Case	Operation summary	Power consumption (w)
UseCase4	Use case assuming 1 screen display (3D graphics × 1& HD video playback × 1)	3.18
	<ul> <li>CortexA55 (2Core/CPU0: use rate 79%, CPU1: use rate 79%)</li> </ul>	
	• GPU: use rate 70%	
	<ul> <li>System/Bus/Clock: use rate 75%</li> </ul>	
	• VCP: use rate 50%	
	MIPI-DSI: use rate 90%	
	MIPI-CSI: use rate 25%	
	• USB2.0: use rate 0%	
	Gbit-Ether: use rate 30%	
	DRAM use rate 66%	

Table 4.1Operation summary of each use case (2/2)



### 4.3 The power consumption in each use case

• Estimation conditions of power consumption

Tj = 125°C, Power supply (1.1V) = 1.1V, Power Supply (DDR4) = 1.2V, Power Supply (1.8V) = 1.8V, Power Supply (3.3V) = 3.3V, Process = FF process silicon, CPU: Cortex-A55@1.2GHz, DDR4-1600 16bit × 1ch

#### Table 4.2The power consumption in each use case

					Unit	:: [W]
Use Case	1.1V	1.2V	1.8V	3.3V	total	
UseCase1	1.81	0.06	0.20	0.56	2.62	
UseCase2	1.99	0.09	0.20	0.56	2.84	
UseCase3	1.86	0.06	0.20	0.56	2.68	
UseCase4	2.28	0.13	0.20	0.56	3.18	



#### 4.4 Limit Ta in each use case (15mm sq)

We calculated Limit Ta<sup>\*1</sup> from  $\theta$  ja which is calculated by thermal simulation.

Limit Ta is shown in the following table. But please remind that the limit Ta and  $\theta$ ja in each use case is reference value based on JEDEC environment, and the Ta and  $\theta$ ja could be fluctuated by the customer use case. The formula of Limit Ta is as follows.

Note 1. Limit Ta is the limit value of Ta to keep the Tjmax within the specified value.

Formula: Limit Ta(°C) = 125(°C) - Pd ×  $\theta$ ja

#### Table 4.3The Limit Ta in each use case(15mm sq)

						Unit: (°C)
		w/o Heat Sinł	K		w/ Heat Sink	(
Use Case	Air Velocity 0m/sec	Air Velocity 1m/sec	Air Velocity 2m/sec	Air Velocity 0m/sec	Air Velocity 1m/sec	Air Velocity 2m/sec
UseCase1	76.8	85.0	85.0	82.6	85.0	85.0
UseCase2	72.7	81.8	84.4	79.0	85.0	85.0
UseCase3	75.7	84.3	85.0	81.6	85.0	85.0
UseCase4	66.5	76.7	79.5	73.5	85.0	85.0

 $\theta$  ja is the following values.

#### Refer to Section 5, Thermal simulation model for the thermal simulation model.

						Unit: (°C)
		w/o Heat Sink	(		w/ Heat Sink	
Use Case	Air Velocity 0m/sec	Air Velocity 1m/sec	Air Velocity 2m/sec	Air Velocity 0m/sec	Air Velocity 1m/sec	Air Velocity 2m/sec
UseCase1	18.4	15.2	14.3	16.2	11.1	10.2
UseCase2	18.4	15.2	14.3	16.2	11.1	10.2
UseCase3	18.4	15.2	14.3	16.2	11.1	10.2
UseCase4	18.4	15.2	14.3	16.2	11.1	10.2

Table 4.4 The  $\theta$  in each use case(15mm sq)



## 4.5 Limit Ta in each use case (21mm sq)

We calculated Limit Ta<sup>\*1</sup> from  $\theta$ ja which is calculated by thermal simulation.

Limit Ta is shown in the following table. But please remind that the limit Ta and  $\theta$ ja in each use case is reference value based on JEDEC environment, and the Ta and  $\theta$ ja could be fluctuated by the customer use case. The formula of Limit Ta is as follows.

Note 1. Limit Ta is the limit value of Ta to keep the Tjmax within the specified value.

Formula: Limit Ta(°C) = 125(°C) - Pd ×  $\theta$ ja

#### Table 4.5The Limit Ta in each use case(21mm sq)

						Unit: (°C)
		w/o Heat Sink			w/ Heat Sink	
	Air Velocity	Air Velocity	Air Velocity	Air Velocity	Air Velocity	Air Velocity
Use Case	0m/sec	1m/sec	2m/sec	0m/sec	1m/sec	2m/sec
UseCase1	78.9	85.0	85.0	85.0	85.0	85.0
UseCase2	75.0	84.1	85.0	82.4	85.0	85.0
UseCase3	77.8	85.0	85.0	84.8	85.0	85.0
UseCase4	69.0	79.2	82.1	77.3	85.0	85.0

 $\theta$  ja is the following values.

#### Refer to **Section 5, Thermal simulation model** for the thermal simulation model.

						Unit: (°C)
		w/o Heat Sink	ĸ		w/ Heat Sink	(
Use Case	Air Velocity 0m/sec	Air Velocity 1m/sec	Air Velocity 2m/sec	Air Velocity 0m/sec	Air Velocity 1m/sec	Air Velocity 2m/sec
UseCase1	17.6	14.4	13.5	15.0	10.3	9.4
UseCase2	17.6	14.4	13.5	15.0	10.3	9.4
UseCase3	17.6	14.4	13.5	15.0	10.3	9.4
UseCase4	17.6	14.4	13.5	15.0	10.3	9.4

Table 4.6 The  $\theta$  ja in each use case(21mm sq)



## 5. Thermal simulation model

## 5.1 Ref : SIMULATION model for thermal analysis (15mm sq)

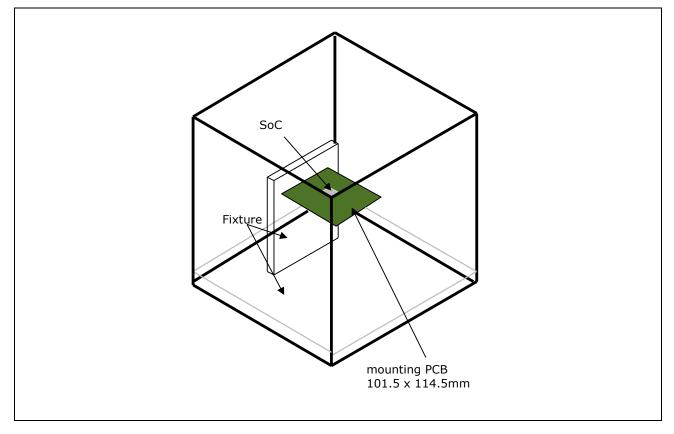


Figure 5.1 external environment based on JESD51-2A

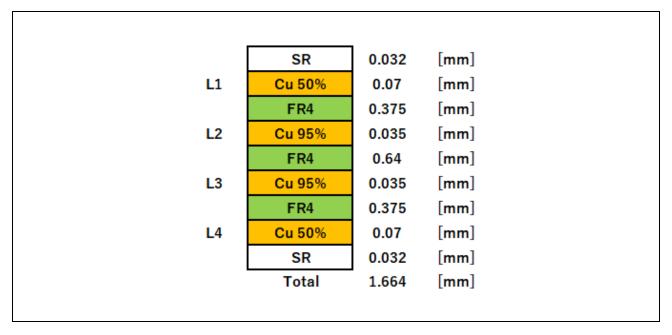


Figure 5.2 mounting PCB layer information based on JESD51-9

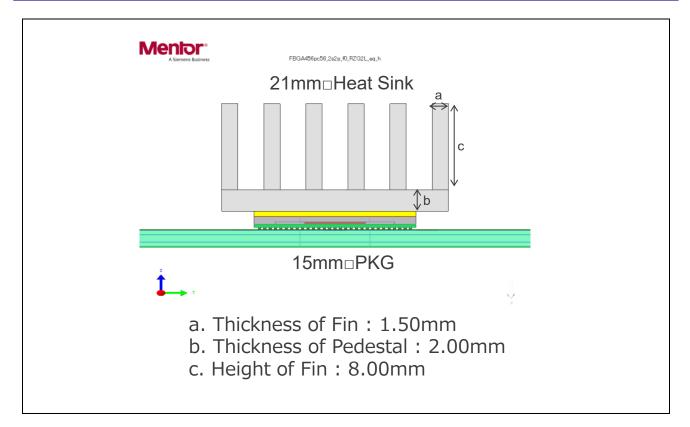
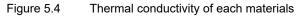


Figure 5.3 Heat Sink information







## 5.2 Ref: SIMULATION model for thermal analysis (21mm sq)

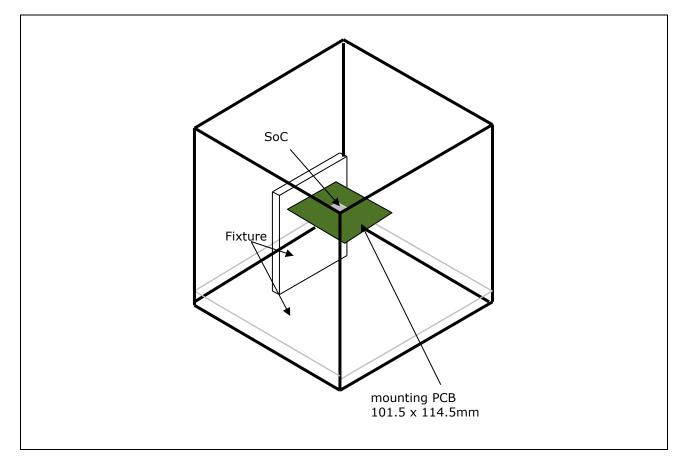
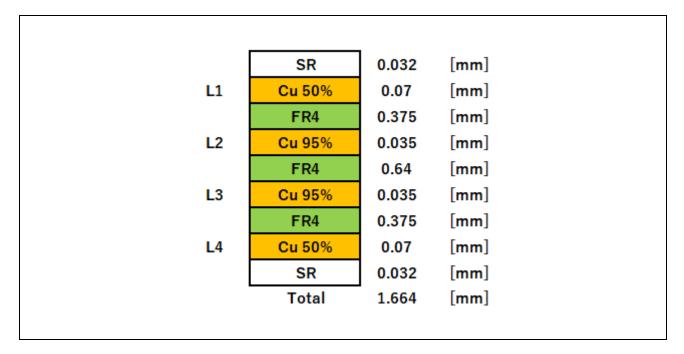
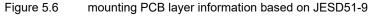


Figure 5.5 external environment based on JESD51-2A





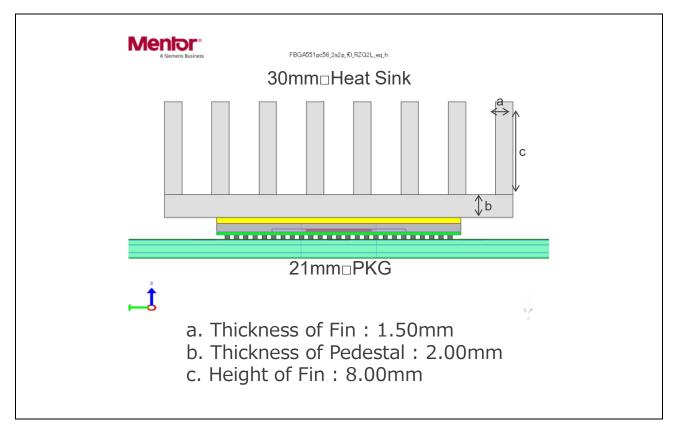
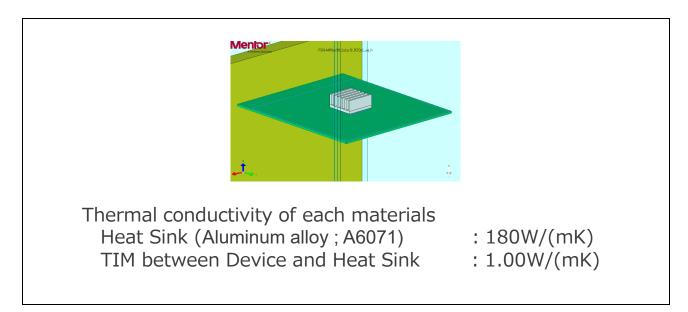


Figure 5.7 Heat Sink information







## 5.3 Ref : Parameter (θjc, θjb)

Table 4.1	Parameter(θjc,	θjb) of 15mm se	q and 21mm sq
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Package Outline	Heat Sink	θjc (°C/W)	θjb (°C/W)
15mm sq	No	7.6	9.9
21mm sq	No	7.2	10.1



# REVISION HISTORY

RZ/G2L Thermal Management Guideline

			Description		
Rev.	Date	Page	Summary		
1.00	Oct 07, 2021		First edition issued		



# General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

1. Precaution against Electrostatic Discharge (ESD)

A strong electrical field, when exposed to a CMOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop the generation of static electricity as much as possible, and quickly dissipate it when it occurs. Environmental control must be adequate. When it is dry, a humidifier should be used. This is recommended to avoid using insulators that can easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors must be grounded. The operator must also be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions must be taken for printed circuit boards with mounted semiconductor devices.

The state of the product is undefined at the time when power is supplied. The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the time when power is supplied. In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the time when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the time when power is supplied until the power is supplied until the power is supplied until the power reaches the level at which resetting is specified.

3. Input of signal during power-off state

Do not input signals or an I/O pull-up power supply while the device is powered off. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Follow the guideline for input signal during power-off state as described in your product documentation.

4. Handling of unused pins

Handle unused pins in accordance with the directions given under handling of unused pins in the manual. The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of the LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible.

5. Clock signals

After applying a reset, only release the reset line after the operating clock signal becomes stable. When switching the clock signal during program execution, wait until the target clock signal is stabilized. When the clock signal is generated with an external resonator or from an external oscillator during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Additionally, when switching to a clock signal produced with an external resonator or by an external oscillator while program execution is in progress, wait until the target clock signal is stable.

6. Voltage application waveform at input pin

Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between  $V_{IL}$  (Max.) and  $V_{IH}$  (Min.) due to noise, for example, the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between  $V_{IL}$  (Max.) and  $V_{IH}$  (Min.).

- Prohibition of access to reserved addresses
   Access to reserved addresses is prohibited. The reserved addresses are provided for possible future expansion of functions. Do not access these
   addresses as the correct operation of the LSI is not guaranteed.
- 8. Differences between products

Before changing from one product to another, for example to a product with a different part number, confirm that the change will not lead to problems. The characteristics of a microprocessing unit or microcontroller unit products in the same group but having a different part number might differ in terms of internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a systemevaluation test for the given product.

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